

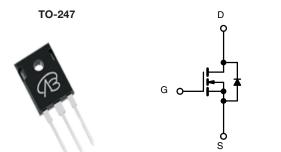
IRFP4227-VB Datasheet N-Channel 200 V (D-S) MOSFET

PRODUCT	SUMMARY		
V _{DS} (V)	R _{DS(on)} (Ω) MAX.	I _D (A)	Q _g (TYP.)
200	0.010at V _{GS} = 10 V	110	75nC

FEATURES

- SGT technology Power MOSFET
- 100 % R_a and UIS tested
- Maximum 175 °C junction temperature





N-Channel MOSFET

APPLICATIONS

- Power supplies:
 - Uninterruptible power supplies
 - AC/DC switch-mode power supplies
 - Lighting
- Synchronous rectification
- DC/DC converter
- Motor drive switch
- DC/AC inverter
- Solar micro inverter
- Class D audio amplifier

ABSOLUTE MAXIMUM RATINGS	$T_C = 25$ °C, unless othe	rwise noted)			
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V _{DS}	200	.,,	
Gate-Source Voltage	V _{GS}	± 20	V		
Continuous Dunis Comment (T. 150 °C)	T _C = 25 °C		110		
Continuous Drain Current (T _J = 150 °C)	T _C = 70 °C	l _D	90		
Pulsed Drain Current (t = 100 μs)		I _{DM}	330	A	
Avalanche Current	L = 0.5 mH	I _{AS}	780	ı	
Single Avalanche Energy ^a	L = 0.5 MH	E _{AS}	110	mJ	
Mariana Baras Biotasia a	T _C = 25 °C	В	300 ^b	10/	
Maximum Power Dissipation ^a	T _C = 100 °C	P _D	150 ^b	W	
Operating Junction and Storage Temperature R	ange	T _J , T _{stg}	-55 to +175	°C	

THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	LIMIT	UNIT	
Junction-to-Ambient (PCB Mount) ^c	R _{thJA}	40	°C/W	
Junction-to-Case (Drain)	R _{thJC}	0.5	C/VV	

Notes

- a. Duty cycle \leq 1 %.
- b. See SOA curve for voltage derating.

Top View

c. When mounted on 1" square PCB (FR4 material).



PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static				•			
Drain-Source Breakdown Voltage	V_{DS} $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ 20		200	-	-		
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2.5	-	4.5	V	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	± 250	nA	
		V _{DS} = 200 V, V _{GS} = 0 V	-	-	1	^	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 160 V, V _{GS} = 0 V, T _J = 125 °C	-	-	150	μA	
		V _{DS} = 160 V, V _{GS} = 0 V, T _J = 175 °C	-	-	5	mA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	90	-	-	Α	
Durin Course On Chata Basistana 2	_	V _{GS} = 10 V, I _D = 30 A	-	0.010	-		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 7.5 V, I _D =30 A	-	0.015	-	Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 30 A	-	75	-	S	
Dynamic ^b							
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 60 V, f = 1 MHz	-	6800	-	pF	
Output Capacitance	C _{oss}		-	246	-		
Reverse Transfer Capacitance	C _{rss}		-	21	-		
Total Gate Charge ^c	Qg		-	75	96		
Gate-Source Charge ^c	Q_{gs}	$V_{DS} = 60 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 60 \text{ A}$	-	16.7	-	nC	
Gate-Drain Charge ^c	Q _{gd}		-	16.9	-		
Gate Resistance	R_g	f = 1 MHz	1.5	3	6	Ω	
Turn-On Delay Time ^c	t _{d(on)}		-	21	33		
Rise Time ^c	t _r	V_{DD} = 60 V, R_L = 1.66 Ω	-	115	220		
Turn-Off Delay Time ^c	t _{d(off)}	$ID\cong 60 \text{ A}, VGEN = 10 \text{ V}, Rg = 1 \Omega$	-	33	71	ns	
Fall Time ^c	t _f		-	90	134		
Drain-Source Body Diode Ratings ar	nd Characteri	stics ^b (T _C = 25 °C)		•			
Pulsed Current (t = 100 μs)	I _{SM}		-	-	330	Α	
Forward Voltage ^a	V _{SD}	I _F = 10 A, V _{GS} = 0 V	-	0.8	1.2	V	
Reverse Recovery Time	t _{rr}		-	170	340	ns	
Peak Reverse Recovery Charge	I _{RM(REC)}	$I_F = 30 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$	-	11	20	Α	
Reverse Recovery Charge	Q _{rr}		-	0.9	1.8	μC	

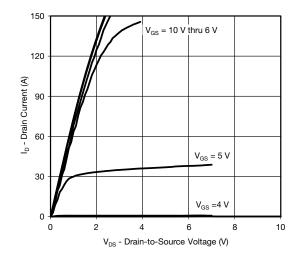
Notes

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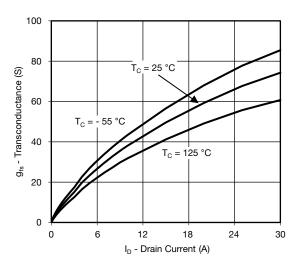
- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing. c. Independent of operating temperature.



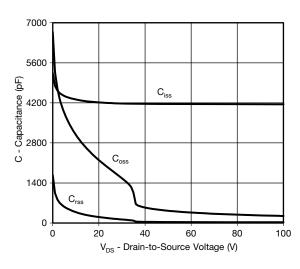
TYPICAL CHARACTERISTICS ($T_A = 25 \, ^{\circ}\text{C}$, unless otherwise noted)



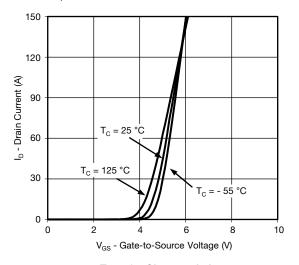
Output Characteristics



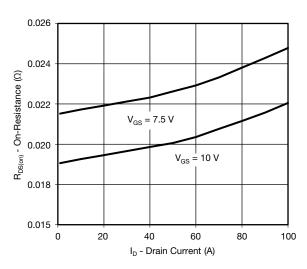
Transconductance



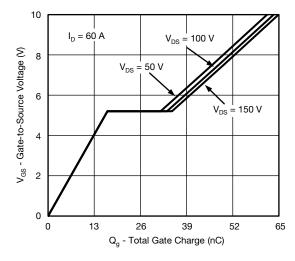
Capacitance



Transfer Characteristics



On-Resistance vs. Drain Current

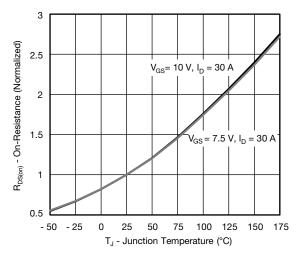


Gate Charge

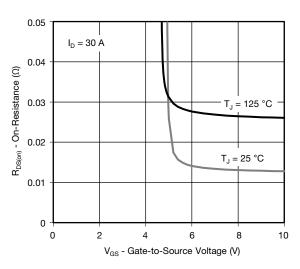
服务热线:400-655-8788 3



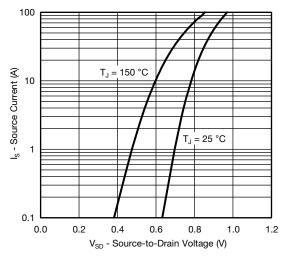
TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)



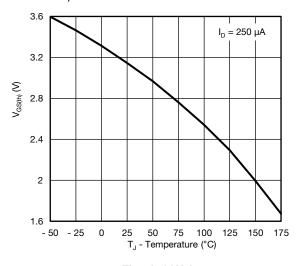
On-Resistance vs. Junction Temperature



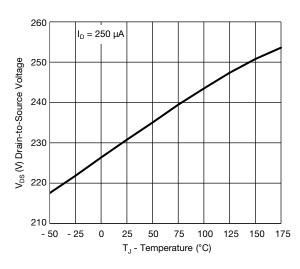
On-Resistance vs. Gate-to-Source Voltage



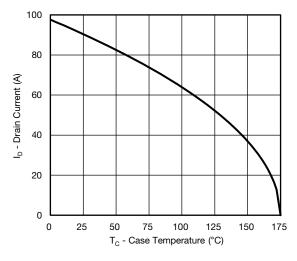
Source Drain Diode Forward Voltage



Threshold Voltage



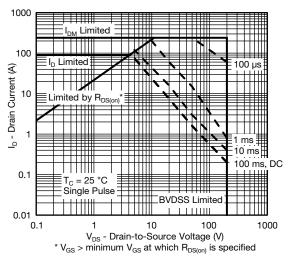
Drain Source Breakdown vs. Junction Temperature

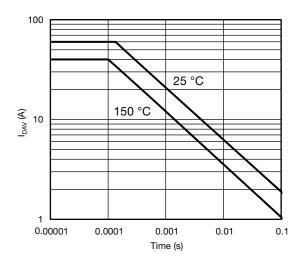


Current De-rating



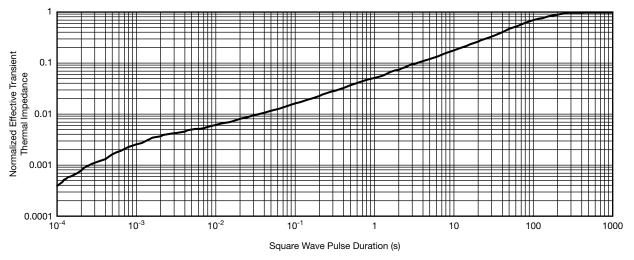
THERMAL RATINGS ($T_A = 25$ °C, unless otherwise noted)





Safe Operating Area

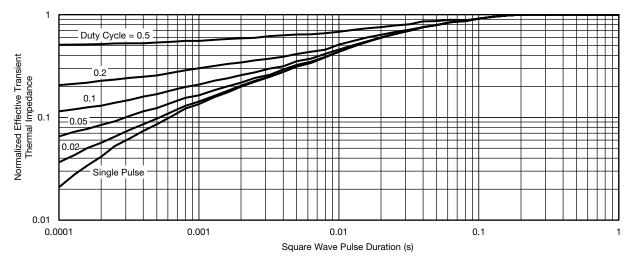
Single Pulse Avalanche Current Capability vs. Time



Normalized Thermal Transient Impedance, Junction-to-Ambient



THERMAL RATINGS (T_A = 25 °C, unless otherwise noted)



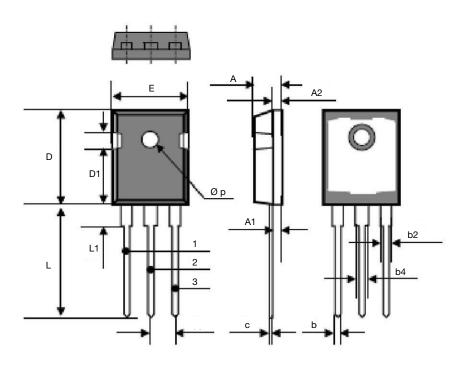
Normalized Thermal Transient Impedance, Junction-to-Case

Note

- The characteristics shown in the two graphs Normalized Transient Thermal Impedance Junction to Ambient (25 $^{\circ}\text{C})$
 - Normalized Transient Thermal Impedance Junction to Case (25 °C) are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.



TO-247



DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
Α	4.70	5.31	0.185	0.209
A1	2.21	2.59	0.087	0.102
A2	1.50	2.49	0.059	0.098
b	0.99	1.40	0.039	0.055
b2	1.65	2.41	0.065	0.095
b4	2.59	3.43	0.102	0.135
С	0.61 BSC		0.024 BSC	
D	20.80	21.46	0.819	0.845
D1	3.68	5.49	0.145	0.216
(e)	5.46 BSC		0.215	BSC
Е	15.49	16.26	0.610	0.640
L	19.81	20.32	0.780	0.800
L1	4.06	4.50	0.160	0.177
Øр	3.51	3.66	0.138	0.144



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